

전력비 변화에 따른 Au Multilayer 위에 증착한 GZOB 박막의 특성

이중환, 이규일, 김봉석, 이태용, 강현일, 송준태

정보통신공학부, 성균관대학교

Dependences of the Power ratio on the properties in GZOB/Au multilayers

Jong-Hwan Lee, Kyu-Il Lee^{*}, Bong-Suk Kim^{**}, Tae-Yong Lee^{***}, Hyun-Il Kang^{****} and Joon-Tae Song^{*****}

Department of Information and Communication Engineering^{*}, SungKyunKwan Univ.^{**}

Abstract : Effects of power ratio on the electrical and optical properties of Au based Ga-, B- codoped ZnO(GZOB) thin films were investigated. GZOB thin films on Au based PC flexible substrate were deposited at various power in the range from 50 to 125 W by DC magnetron sputtering. Au layer was fabricated to achieve good electrical conductivity. The presence of additional boron impurity leads to improve structural defects. Thus, the c-axis orientation along (002) plane was enhanced with the increasing of power ratio and the surface morphology of the films showed a homogeneous and nano-sized microstructure. GZOB films grown at 125W were investigated a low resistivity value of $1 \times 10^{-3} \Omega\text{cm}$, and a visible transmission of 80% with a thickness of 300nm.

Key Words : GZOB; multilayer; Au; DC magnetron sputtering; power ratio